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Application/Control No.	Applicant(s)/Patent under Reexamination
10/649,258	BENCO ET AL.
Examiner	Art Unit
 Tu X. Nguyen	2618

	SFAR	CHED	
SEARCHED			
Class	Subclass	Date	Examiner
455	436	9/7/2006	TN
	422		
	417		
	445		
	527		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			-

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
Search East	9/7/2006	TN